

<b>Issue Classification</b>			Application/Control No.	Applicant(s)/Patent under Reexamination
			10/759,339	BECKER ET AL.
Examiner			Art Unit	
Hiep Nguyen			2816	

ORIGINAL			CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
327	374	327	375	376	377			
INTERNATIONAL CLASSIFICATION								
H	03	K	17	104				
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HIEP NGUYEN 10.18.05 (Assistant Examiner) (Date)			TUAN T. LAM PRIMARY EXAMINER (Primary Examiner)			Total Claims Allowed: 2		
Anne Y. Smith 10/29/05 (Legal Instruments Examiner) (Date)			10/20/05 (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 4A	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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